

**Search Notes**

Application/Control No.

10/697,060

Examiner

Jason M. Han

Applicant(s)/Patent under  
Reexamination

STEEN ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	109	1/11/2006	JMH
362	119-120	1/11/2006	JMH
362	186	1/11/2006	JMH
362	554-556	1/11/2006	JMH
362	572-575	1/11/2006	JMH
385	117, 902	1/11/2006	JMH
600	245-249	1/18/2006	JMH
606	4, 6, 16	1/18/2006	JMH
607	88, 92-93	1/18/2006	JMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST (US-PGPUB) - See Interference Printout		1/11/2006	JMH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	1/11/2006	JMH
P.E. Alan Cariaso	1/11/2006	JMH
Inventor Search	1/11/2006	JMH
P.E. Ahmed Farah - Class 606	1/18/2006	JMH
P.E. Scott Getzow - Class 600 & 607	1/18/2006	JMH
Reviewed 10/189,675	1/18/2006	JMH